

The Royal Microscopical Society presents

Aberration Corrected & Quantitative (S)TEM & Advances in Tomography III



11th – 12th April 2011, University of Sheffield

Meeting information

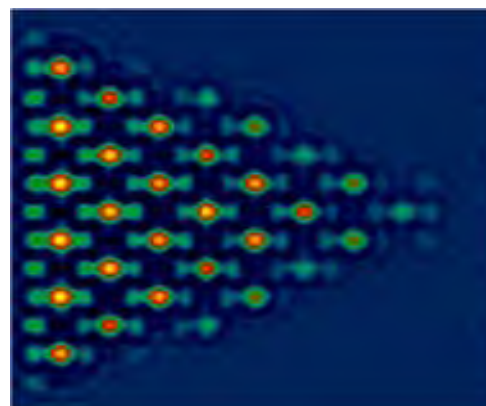


Mappin Hall, University of Sheffield

Aberration Corrected & Quantitative (S)TEM

Scope and Content:

- Aberration Correction in TEM/ STEM
- Monochromation and Energy filters
- In-Situ TEM, Dynamic TEM
- Atomic resolution TEM
- Quantitative Image Interpretation

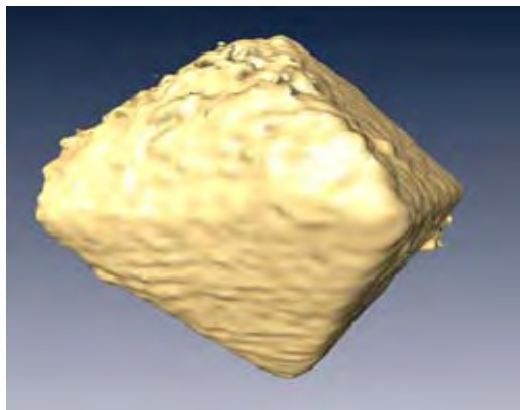


Contributed papers

(oral or posters) are warmly welcomed.

Please visit:

http://www.rms.org.uk/events/Forthcoming_Events/TEMandTOM



Advances in Tomography III

Scope and Content:

- Biological (TEM, light microscope)
- Materials (TEM, SEM, FIB, X-rays)
- Multidisciplinary Tomography
- Novel Optical & Diffraction Tomography
- Reconstruction algorithms

Speakers include

TEM (11th):

- Angus Kirkland, Oxford
- Max Haider, CEOS,
- Jun Yuan, York
- Lothar Houben, Juelich
- Thomas Walther & Ian Ross, Sheffield

TOM (12th):

- Sara Bals, Antwerp
 - Phil Withers, Manchester
 - Christian Schroer, Dresden
 - Heiner Friedrich, Utrecht
 - Tobias Starborg, Manchester
- (Further names to be confirmed)

Sponsors

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Gatan, JEOL

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VSGIII

For further details contact: Victoria Lee, victoria@rms.org.uk

This meeting is organised by the Royal Microscopical Society, 37/38 St Clements Street, Oxford, OX4 1AJ, UK, t: +44 (0)1865 254760, w: www.rms.org.uk, Registered Charity No: 241990

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